

Notice of References Cited	Application/Control No. 10/724,892	Applicant(s)/Patent Under Reexamination CHANG ET AL.	
	Examiner David Y. Chung	Art Unit 2871	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,768,535	07-2004	Yasukawa et al.	349/187
*	B	US-6,504,585	01-2003	Ohkawara et al.	349/38
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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